

# Comparing all wavelenghts

#characteristic\_lenghts

#ell

#ellDW

#ellCC

We can measure three characteristic wavelenghts in the system:

$\ell$

$$\langle q^2 \rangle \equiv \frac{\int q^2 |u_q|^2 dq}{\int |u_q|^2 dq}$$

$$\ell \equiv \frac{2\pi}{\sqrt{\langle q^2 \rangle}}$$

We know from [Linear regime](#) that, during the linear regime

$$\ell \sim t^{\frac{1}{2}}$$

Then, in appendix G of the [Master Report.pdf](#) we show that, asymptotically this wavelength is related to  $\ell_{DW}$  that asymptotically shows the coarsening exponent  $\frac{1}{2}$ :  $\ell_{DW} \sim t^{\frac{1}{2}}$  so

$$\ell \sim t^{\frac{1}{4}}$$

$\ell_{DW}$

$$\ell_{DW} = \frac{L^2}{\int |\nabla u|^2 dx dy} * W$$

Where  $W$  is the width of the interface, defined as the integral of the derivative of the field  $u(x, y)$  along a direction perpendicular to the interface. We estimate this integral by considering the stationary state with  $C = \bar{C}$ :

$$u_k(\xi) = \sqrt{C} \tanh\left(\sqrt{\frac{C}{2}} \xi\right)$$

$$W = \int_{-\infty}^{\infty} (\partial_{\xi} u_k(\xi))^2 d\xi = \frac{2}{3} \sqrt{2} C^{\frac{3}{2}}$$

(the last integral is calculated in Appendix G of the [Master Report.pdf](#)).

As the gradient is peaked in the regions close to the interfaces,  $\ell_{DW}$  should estimate the ratio between the size of the system  $L^2$  and the (total) length of the interfaces  $\mathcal{L}$ .

$\ell_{CC}$

We estimate the (total) length of the interfaces  $\mathcal{L}$  by using the Cauchy-Crofton theorem, using 4 families of parallel lines: horizontal, vertical,  $\pi/4$ ,  $3\pi/4$ . Then we calculate

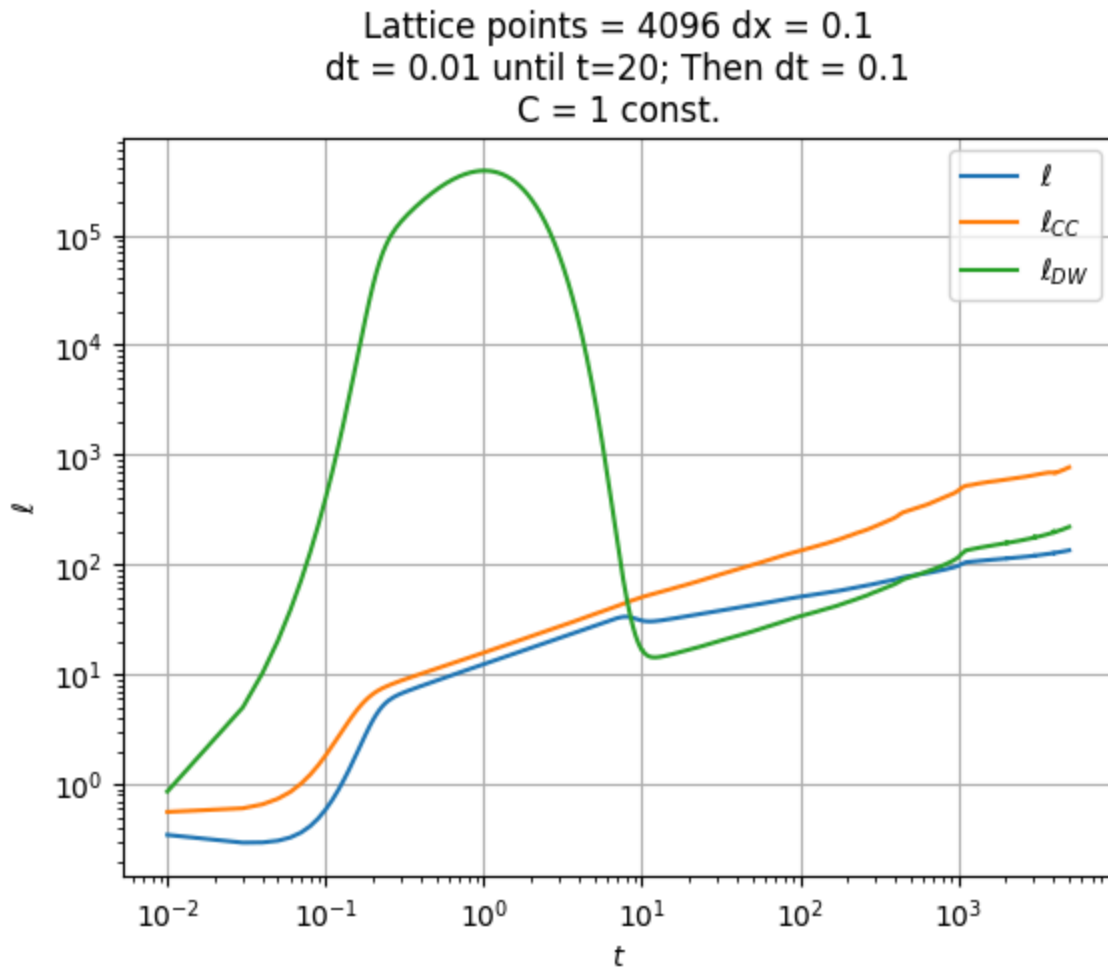
$$\ell_{CC} = \frac{L^2}{\mathcal{L}}$$

The Cauchy-Croft formula is

$$\mathcal{L} \simeq \frac{1}{2} * n * dx * (\pi/4)$$

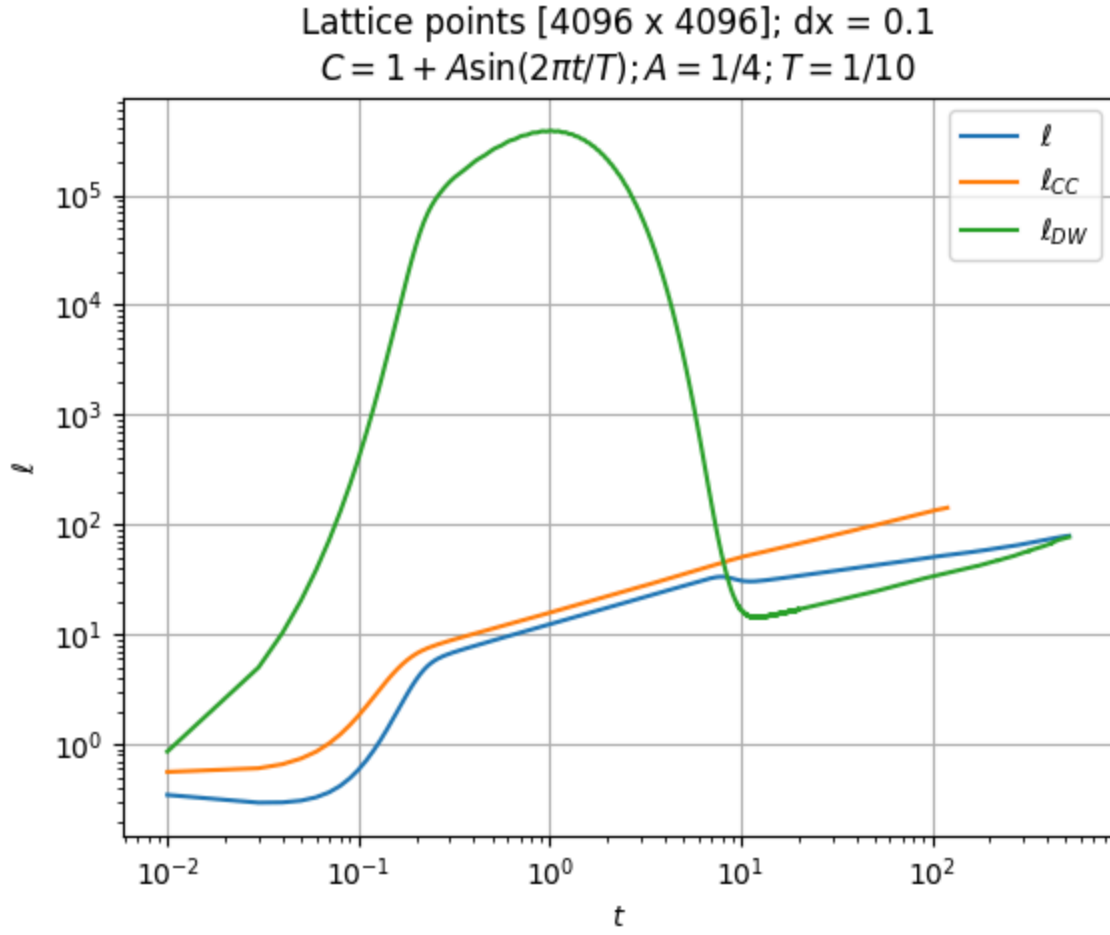
- $n$  is the number of times the interface crosses the parallel lines
- $dx$  is the spacing between the lines

## Comparison (in the same canvas)



In the following plot, the thickness of the interface is estimated as the one of the stationary state

associated with constant  $C = \bar{C}$ .



## Comparison (Asymptotically)

Asymptotically, precisely when  $\ell_{DW}$  well estimates the ratio  $L^2/\mathcal{L}$ :

$$\ell^{-2} \simeq (2\pi)^{-2} D^{-1} I_1 (C\ell_{DW} - I_2)^{-1}$$

Then, at sufficiently large times:  $\ell_{DW}$  grows, so  $(C\ell_{DW} - I_2) \simeq C\ell_{DW}$  that means

$$\ell^{-2} = (2\pi)^{-2} (CD\ell_{DW})^{-1} I_1$$

Calculating the logarithm:

$$\log \ell = \frac{1}{2} \log \ell_{DW} + \text{const.}$$

$$\text{const.} = \log 2\pi + \frac{1}{2} \log(CD) - \frac{1}{2} \log I_1$$

Lattice points = 4096  $dx = 0.1$   
 $dt = 0.01$  until  $t=20$ ; Then  $dt = 0.1$   
 $C = 1$  const.

